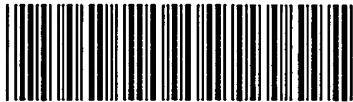


**Search Notes**

Application/Control No.

10/722,884

Examiner

Matthew Bradley

Applicant(s)/Patent under  
Reexamination

IYER, RAVISHANKAR R.

Art Unit

2187

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Call db's (classified keyword)	See attached	MB
PALM (inventor name)	1/13/06	MB
Christian Chace Matthew Anderson (search strategy)	1/9/06	MB
Brian Peugh (allowable matter)	1/10/06	MB
TC 2100 - EIC Fast and focused search	1/12/06	MB